

### **PHOTOCOUPLER**

## PS9687L1,PS9687L2

# HIGH CMR, 10 Mbps OPEN COLLECTOR OUTPUT TYPE 8-PIN DIP PHOTOCOUPLER FOR CREEPAGE DISTANCE OF 8 mm -NEPOC Series-

### **DESCRIPTION**

The PS9687L1 and PS9687L2 are optically coupled isolators containing a GaAlAs LED on the input side and a photo diode and a signal processing circuit on the output side on one chip.

The PS9687L1 and PS9687L2 are designed specifically for long creepage-distance as well as high common mode transient immunity (CMR) and high speed digital output type. Consequently, they are suitable for high speed logic interface that needs long creepage-distance (8 mm) on mounting.

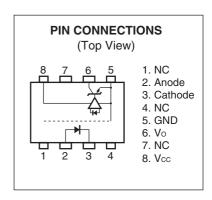
The PS9687L1 is in a plastic DIP (Dual In-line Package) and the PS9687L2 is lead bending type (Gull-wing) for surface mounting.

#### **FEATURES**

- · Long creepage distance (8 mm MIN.)
- High common mode transient immunity (CMH, CML =  $\pm 20 \text{ kV/}\mu\text{s}$  TYP.)
- High isolation voltage (BV = 5 000 Vr.m.s.)
- High-speed response (10 Mbps)
- Pulse width distortion ( | tPHL tPLH | = 15 ns TYP.)
- · Open collector output
- Ordering number of tape product: PS9687L2-E3, E4: 1 000 pcs/reel
- Safety standards
  - UL approved: File No. E72422
  - BSI approved: No. 8990/8991
  - DIN EN60747-5-2 (VDE0884 Part2) approved: No.40008906 (Option)

### APPLICATIONS

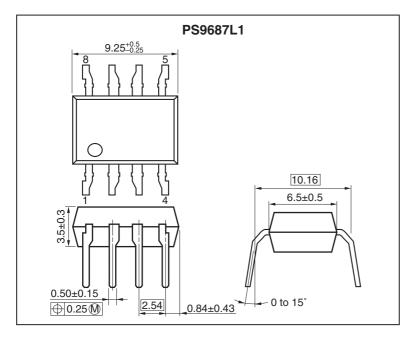
- FA Network
- Measurement equipment
- PDP



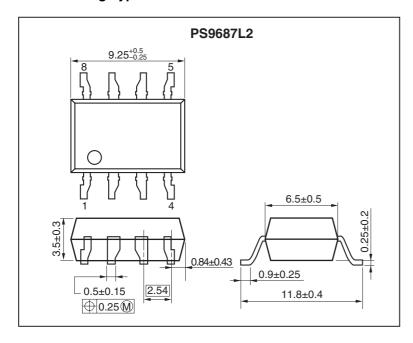
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### PACKAGE DIMENSIONS (UNIT: mm)

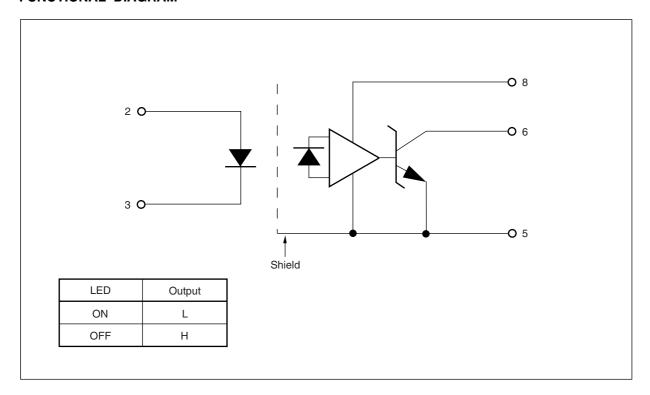
### **DIP Type**



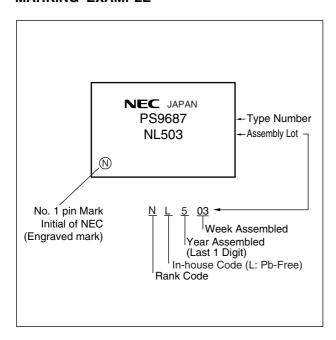
### **Lead Bending Type**



### **FUNCTIONAL DIAGRAM**



### **MARKING EXAMPLE**



### **ORDERING INFORMATION**

Part Number	Order Number	Solder Plating Specification	Packing Style	Safety Standard Approval	Application Part Number*1
PS9687L1	PS9687L1-A	Pb-Free	Magazine case 50 pcs	Standard products	PS9687L1
PS9687L2	PS9687L2-A			(UL, BSI approved)	PS9687L2
PS9687L2-E3	PS9687L2-E3-A		Embossed Tape 1 000 pcs/reel		
PS9687L2-E4	PS9687L2-E4-A				
PS9687L1-V	PS9687L1-V-A		Magazine case 50 pcs	DIN EN60747-5-2	PS9687L1
PS9687L2-V	PS9687L2-V-A			(VDE0884 Part2)	PS9687L2
PS9687L2-V-E3	PS9687L2-V-E3-A		Embossed Tape 1 000 pcs/reel	approved (Option)	
PS9687L2-V-E4	PS9687L2-V-E4-A				

<sup>\*1</sup> For the application of the Safety Standard, following part number should be used.

### ABSOLUTE MAXIMUM RATINGS (TA = 25°C, unless otherwise specified)

Parameter		Symbol	Ratings	Unit	
Diode	Forward Current	lF	30	mA	
	Reverse Voltage	VR	5	V	
Detector	Detector Supply Voltage		7	V	
	Output Voltage	Vo	7	V	
	Output Current	lo	25	mA	
	Power Dissipation*2	Pc	40	mW	
Isolation Voltage <sup>*3</sup>		BV	5 000	Vr.m.s.	
Operating Ambient Temperature		TA	-40 to +85	°C	
Storage Temperature		T <sub>stg</sub>	-55 to +125	°C	

<sup>\*1</sup> Reduced to 0.3 mA/ $^{\circ}$ C at T<sub>A</sub> = 25 $^{\circ}$ C or more.

### RECOMMENDED OPERATING CONDITIONS (TA = 25°C)

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
High Level Input Current	lғн	6.3	10	12.0	mA
Low Level Input Voltage	V <sub>FL</sub>	0		0.8	V
Supply Voltage	Vcc	4.5	5.0	5.5	٧
TTL (R∟ = 1 kΩ, loads)	N			5	
Pull-up Resistance	RL	330		4 k	Ω

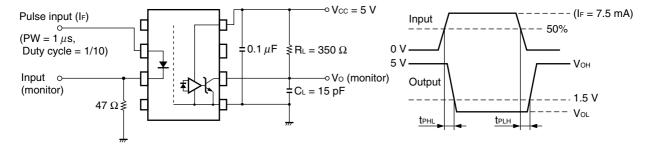
<sup>\*2</sup> Applies to output pin Vo (Collector pin). Reduced to 1.5 mW/°C at TA = 65°C or more.

<sup>\*3</sup> AC voltage for 1 minute at  $T_A = 25^{\circ}$ C, RH = 60% between input and output. Pins 1-4 shorted together, 5-8 shorted together.

### ELECTRICAL CHARACTERISTICS ( $T_A = -40 \text{ to } +85^{\circ}\text{C}$ , unless otherwise specified)

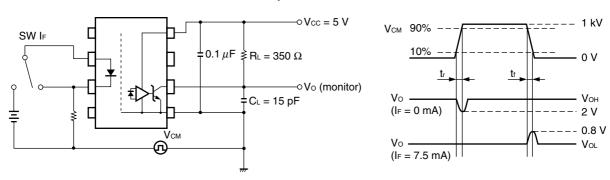
Parameter		Symbol	Conditions		TYP.*1	MAX.	Unit
Diode	Forward Voltage	ward Voltage V <sub>F</sub> I <sub>F</sub> = 10 mA, T <sub>A</sub> = 25°C		1.4	1.65	1.8	V
	Reverse Current	IR	V <sub>R</sub> = 3 V, T <sub>A</sub> = 25°C			10	μА
	Terminal Capacitance	Ct	V <sub>F</sub> = 0 V, f = 1 MHz, T <sub>A</sub> = 25°C		30	150	pF
Detector	or High Level Output Current IoH Vcc = Vo = 5.5 V, V <sub>F</sub> = 0.8 V				1	100	μА
	Low Level Output Voltage <sup>2</sup>	Vol	Vcc = 5.5 V, I <sub>F</sub> = 5 mA, I <sub>OL</sub> = 13 mA		0.35	0.6	V
	High Level Supply Current	Іссн	Vcc = 5.5 V, I <sub>F</sub> = 0 mA, Vo = Open		6	10	mA
	Low Level Supply Current	Iccl	Vcc = 5.5 V, I <sub>F</sub> = 10 mA, Vo = Open		11	13	mA
Coupled	Threshold Input Current $(H \rightarrow L)$	IFHL	$Vcc = 5 \text{ V}, Vo = 0.8 \text{ V}, R_L = 350 \Omega$		2.5	5	mA
	Isolation Resistance	Rı-o	V <sub>I-O</sub> = 1 kV <sub>DC</sub> , RH = 40 to 60%, T <sub>A</sub> = 25°C	10 <sup>11</sup>			Ω
	Isolation Capacitance	Cı-o	V = 0 V, f = 1 MHz, T <sub>A</sub> = 25°C		0.9	5	pF
	Propagation Delay Time	<b>t</b> PHL	Vcc = 5 V, T <sub>A</sub> = 25°C		40	75	ns
	$(H \rightarrow L)^{*3}$		$R_L = 350 \ \Omega$ , $I_F = 7.5 \ mA$ , $C_L = 15 \ pF$			100	
	Propagation Delay Time	tрLн	T <sub>A</sub> = 25 °C		55	75	ns
	$(L \rightarrow H)^{*3}$					100	
	Rise Time	tr			20		ns
	Fall Time	tf			10		ns
	Pulse Width Distortion (PWD) '3	tphl-tplh			15	50	ns
	Propagation Delay Skew	tpsk				60	ns
	Common Mode Transient Immunity at High Level Output <sup>*4</sup>	СМн	$\label{eq:Vcc} \begin{array}{l} \mbox{Vcc} = 5 \mbox{ V, T}_{\mbox{\scriptsize A}} = 25^{\circ}\mbox{C, I}_{\mbox{\scriptsize F}} = 0 \mbox{ mA,} \\ \mbox{Vo}_{(\mbox{\scriptsize MIN.})} = 2 \mbox{ V, V}_{\mbox{\scriptsize CM}} = 1 \mbox{ kV, R}_{\mbox{\scriptsize L}} = 350 \ \Omega \end{array}$		20		kV/μs
	Common Mode Transient Immunity at Low Level Output <sup>*4</sup>	CM∟	$V_{\text{CC}} = 5 \text{ V}, \text{ Ta} = 25^{\circ}\text{C}, \text{ IF} = 7.5 \text{ mA},$ $V_{\text{O} \text{ (MAX.)}} = 0.8 \text{ V}, \text{ V}_{\text{CM}} = 1 \text{ kV}, \text{ RL} = 350 \ \Omega$		20		kV/μs

- \*1 Typical values at T<sub>A</sub> = 25°C
- \*2 Because Vol of 2 V or more may be output when LED current is input and when output power supply is on and off, confirm the characteristics (operation with the power supply on and off) during design, before using this device.
- \*3 Test circuit for propagation delay time



Remark C<sub>L</sub> includes probe and stray wiring capacitance.

\*4 Test circuit for common mode transient immunity

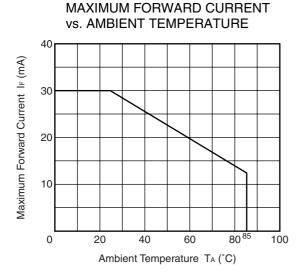


Remark CL includes probe and stray wiring capacitance.

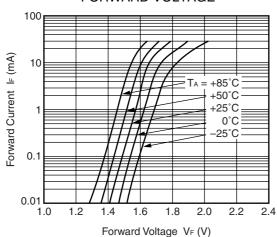
### **USAGE CAUTIONS**

- 1. This product is weak for static electricity by designed with high-speed integrated circuit so protect against static electricity when handling.
- 2. By-pass capacitor of more than 0.1  $\mu$ F is used between Vcc and GND near device. Also, ensure that the distance between the leads of the photocoupler and capacitor is no more than 10 mm.
- 3. Avoid storage at a high temperature and high humidity.

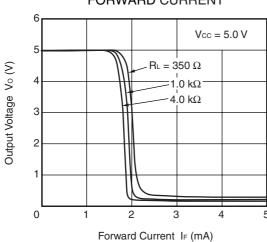
### TYPICAL CHARACTERISTICS (TA = 25°C, unless otherwise specified)



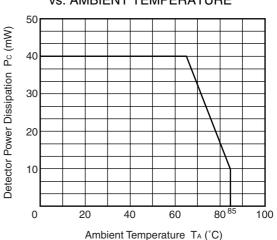




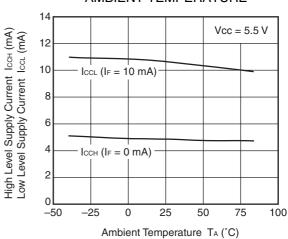
OUTPUT VOLTAGE vs. FORWARD CURRENT



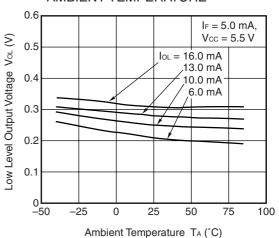
DETECTOR POWER DISSIPATION vs. AMBIENT TEMPERATURE



SUPPLY CURRENT vs.
AMBIENT TEMPERATURE

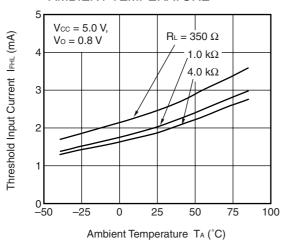


LOW LEVEL OUTPUT VOLTAGE vs. AMBIENT TEMPERATURE

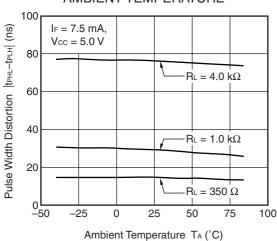


**Remark** The graphs indicate nominal characteristics.

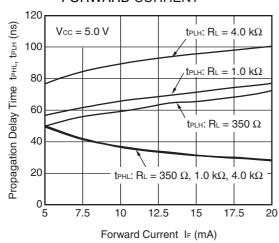
### THRESHOLD INPUT CURRENT vs. AMBIENT TEMPERATURE



### PULSE WIDTH DISTORTION vs. AMBIENT TEMPERATURE

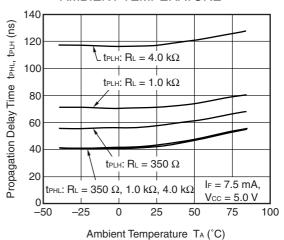


### PROPAGATION DELAY TIME vs. FORWARD CURRENT

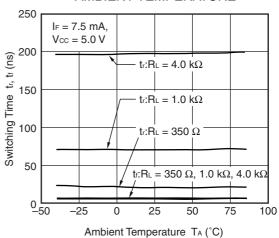


### Remark The graphs indicate nominal characteristics.

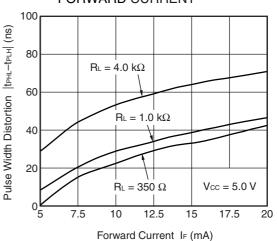
### PROPAGATION DELAY TIME vs. AMBIENT TEMPERATURE



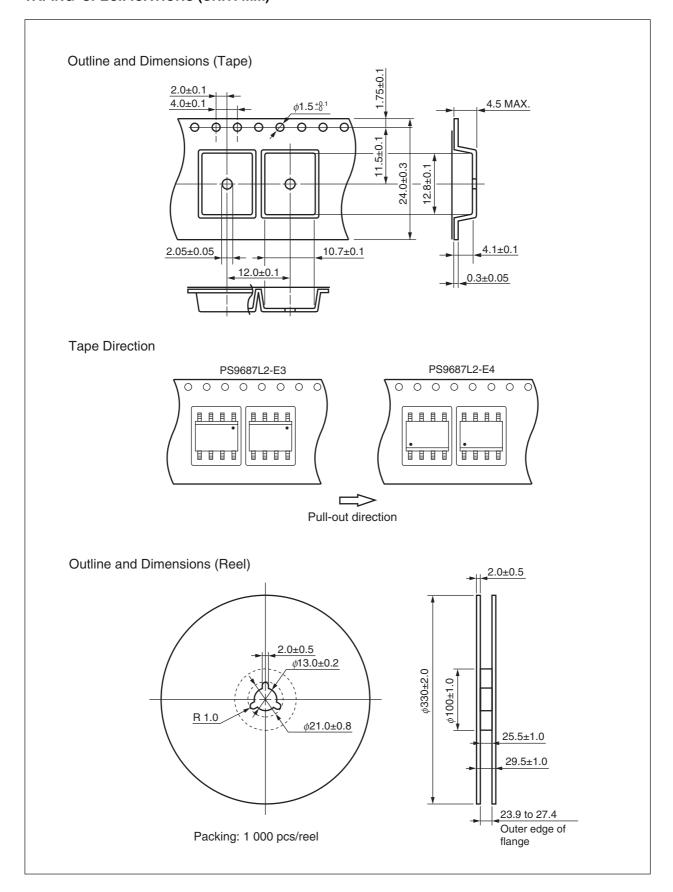
### SWITCHING TIME vs. AMBIENT TEMPERATURE



### PULSE WIDTH DISTORTION vs. FORWARD CURRENT



### TAPING SPECIFICATIONS (UNIT: mm)



### NOTES ON HANDLING

### 1. Recommended soldering conditions

### (1) Infrared reflow soldering

Peak reflow temperature
 260°C or below (package surface temperature)

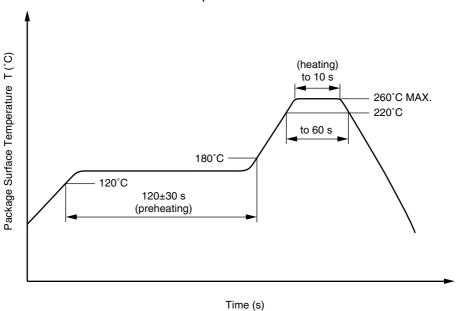
Time of peak reflow temperature
 Time of temperature higher than 220°C
 60 seconds or less

Time to preheat temperature from 120 to 180°C 120±30 s
 Number of reflows Three

Flux
 Rosin flux containing small amount of chlorine (The flux with a

maximum chlorine content of 0.2 Wt% is recommended.)

### Recommended Temperature Profile of Infrared Reflow



### (2) Wave soldering

• Temperature 260°C or below (molten solder temperature)

• Time 10 seconds or less

Preheating conditions 120°C or below (package surface temperature)

Number of times
 One (Allowed to be dipped in solder including plastic mold portion.)

• Flux Rosin flux containing small amount of chlorine (The flux with a maximum chlorine

content of 0.2 Wt% is recommended.)

#### (3) Soldering by Soldering Iron

Peak Temperature (lead part temperature) 350°C or below
 Time (each pins) 3 seconds or less

• Flux Rosin flux containing small amount of chlorine (The flux with a

maximum chlorine content of 0.2 Wt% is recommended.)

(a) Soldering of leads should be made at the point 1.5 to 2.0 mm from the root of the lead

(b) Please be sure that the temperature of the package would not be heated over 100°C

### (4) Cautions

• Fluxes

Avoid removing the residual flux with freon-based and chlorine-based cleaning solvent.

### 2. Cautions regarding noise

Be aware that when voltage is applied suddenly between the photocoupler's input and output or between collectoremitters at startup, the output transistor may enter the on state, even if the voltage is within the absolute maximum ratings.

#### **USAGE CAUTIONS**

- 1. Protect against static electricity when handling.
- 2. Avoid storage at a high temperature and high humidity.

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M8E 00.4-0110

### Caution

**GaAs Products** 

This product uses gallium arsenide (GaAs).

GaAs vapor and powder are hazardous to human health if inhaled or ingested, so please observe the following points.

- Follow related laws and ordinances when disposing of the product. If there are no applicable laws and/or ordinances, dispose of the product as recommended below.
  - Commission a disposal company able to (with a license to) collect, transport and dispose of materials that contain arsenic and other such industrial waste materials.
- 2. Exclude the product from general industrial waste and household garbage, and ensure that the product is controlled (as industrial waste subject to special control) up until final disposal.
- Do not burn, destroy, cut, crush, or chemically dissolve the product.
- Do not lick the product or in any way allow it to enter the mouth.

#### ▶ For further information, please contact

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